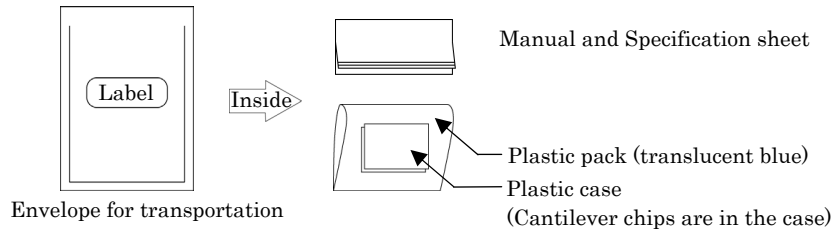


Micro cantilever user's manual

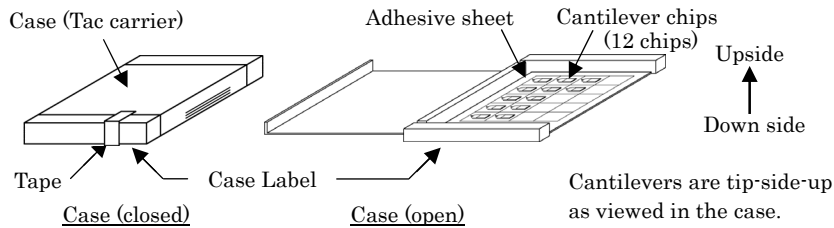
Thank you for purchasing OLYMPUS Micro cantilever.
Please read this manual carefully before use.

< Explanation of the each part of the products >

Cantilever chips in a plastic case are included in the envelope with manual and spec. sheet.



Cantilever chips are contained in the plastic case (Tac carrier)



Magnified illust.

Micro Cantilever		
OMCL-AC160RN-A2		
LotNo.		
Typical Value	Inspection result	Quality inspection
Resonant frequency 300 (kHz)		
Spring constant 42 (N/m)	(Calculated Value)	
http://www.olympus.co.jp/probe/ OLYMPUS		

Lot Number

Inspection stamp

One cantilever elongates from the side of round shoulders of the chip.

Please obey the following to the OLYMPUS micro cantilevers

Warning

- Use protective eye glasses when handling to avoid damage to the eyes from breakage of the cantilever chips.



Caution

- Please handle our cantilevers carefully because they are fragile.

Caution

- Do not drop or shake the cantilever case. Even when the cantilever chips are contained in the cantilever case, the cantilevers may break if the case is handled roughly or jarred.

Caution

- It is recommended that precautions be taken to prevent damage to the cantilever tips from electrostatic discharge.

Caution

- When discarding, please obey the laws and regulations in your country and/or your company. These cantilevers are made from silicon.

Special feature of OLYMPUS Micro cantilever (OMCL-AC160BN-W2)

1. **AC mode cantilever** – This type of micro cantilever is for AC (dynamic) mode AFM operation. High mechanical Q factor of the cantilevers allows you high sensitivity measurement to probe your sample surface gently.
2. **Tip View** – The tip is located on the very end of the cantilever. This feature allows you to set the tip over a point of interest on the sample, easily and precisely, if you use an AFM combined with an optical microscope.
3. **High aspect ratio tip** – A blade-like tetrahedral tip of single crystal silicon (Blade tetra tip) is employed for high-resolution measurements. The Blade tetra tip is a thinner designed than our standard Tetrahedral tips on our OMCL-AC***TS- series cantilever. The tetrahedral shape is ideal for achieving a point terminated tip. In addition to the geometrical dimensions of the tip, the tip is further sharpened with our exclusive sharpening process. Therefore, in viewing along the cantilever axis, the last 2 μm of the tip has a high aspect ratio typically 7:1 corresponding to a half tip angle of 6 degrees or less. (see Chapter 6) The Blade tetra tip is suitable for measuring striped line patterns, lined electrodes, optical disc pits, groove array etc.
4. **Compatible chip size** – 3.4 mm(L) x 1.6 mm(W) x 0.3 mm(t) This type of the chip can be attached to most of AFM instruments.
5. **Easy handling** – Chip are fixed through the support arms. (Bottom left illust. in the first page) 375 chips are contained in a wafer. A chip can be separated from the wafer frame by pushing it gently in the middle with a pair of tweezers.
6. **No metal reflex coating**

See the specification sheet of OLYMPUS Micro cantilevers at the last page of this manual.

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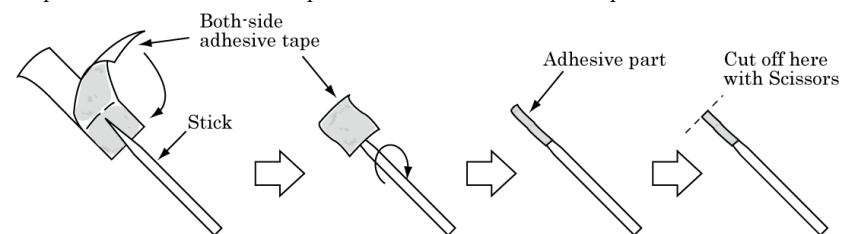
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7	Specification 1s

1 Preparation

- 1) Please prepare the followings before using OLYMPUS cantilevers.
- 2) To gain a better understanding of how cantilevers and chips are connected, cantilevers should be inspected under the microscope.

- | | |
|-----------------------------|--|
| 1) Work environment | : <u>Clean bench</u>
(Use of an electrical charge neutralizer or ionizer is recommended.) |
| 2) For hazard avoidance | : <u>Protective eye glasses</u> |
| 3) For cantilever treatment | : <u>Tweezers, Thin bamboo stick</u>
(Use of those made of insulator is recommended.)
: <u>Both-side adhesive tape, Scissors</u>
(Use of anti-electrostatic discharge mat and a wrist band is recommended.) |
| 4) For inspection | : <u>Stereo microscope</u> |

- 3) Wind both-side adhesive tape around the top of the thin stick to prepare an adhesive stick for picking up the chips from Tac carrier case.
- 4) Cut the top of the wound adhesive tape with scissors to make the top of the adhesive flat.



The way to make an adhesive stick

2 Open the case

⚠ Caution

- Please handle our cantilevers carefully because they are fragile.


⚠ Caution

- It is recommended that precautions be taken to prevent damage to the cantilever tips from electrostatic discharge.

- 1) It is recommended that the cantilever case be opened in a clean environment like a clean bench in order to avoid the cantilever being contaminated. Handling under an ionizer is recommended.
- 2) Avoid wearing clothes like woolen sweaters, fleece etc that give off the static electricity when handling the cantilever cases and chips. Use of an anti-electrostatic mat and wrist band is preferable.


- 3) In opening the case, put the plastic case label-side down on a desk.
The cantilevers are tip-side-up as viewed in the case.
- 4) Open the case.

3 Picking up the cantilever chip from the case



Caution

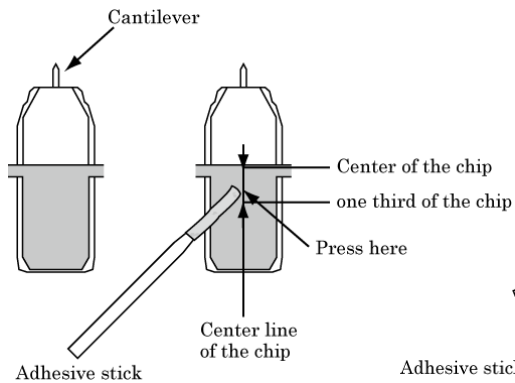
- Avoid any contact with the cantilevers when you pull up the cantilever tip from the case.



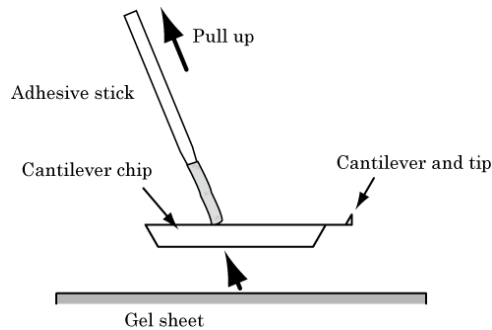
Caution

- Cantilever chips should always be placed tip-side-up.

- 1) Press down gently on the part between the center and one third of the chip along the center line with the adhesive stick (see left below)



- 2) Do not press the chip too much, or the chip might be buried in the Gel sheet and the cantilever must break.
- 3) Pull up the tick carefully, then the adhered chip is picked up together (see below).



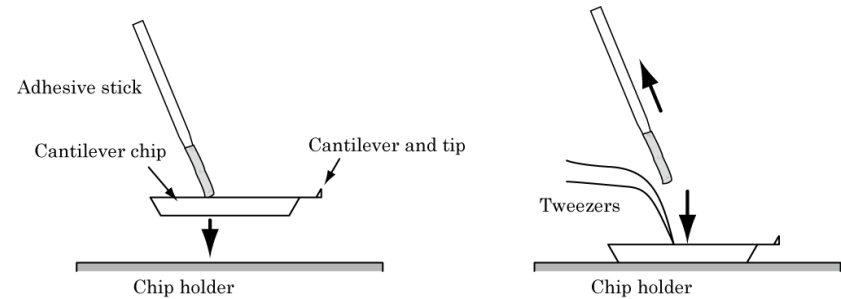
Note : Some of the both-side adhesive tapes have not enough adhesive to pick up the chip from the Gel sheet. Then use the tweezers for this procedure.

4 Attaching the cantilever chips to your instrument

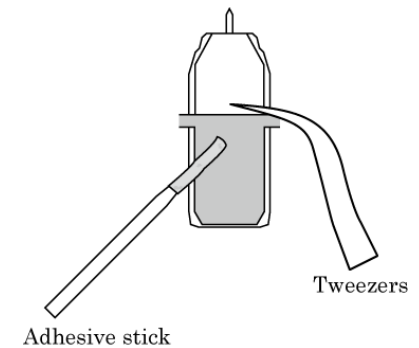
- 1) Please read the instruction manual of your scanning probe microscope before this operation.

To attach the cantilever chip to the holder in your scanning probe microscope,

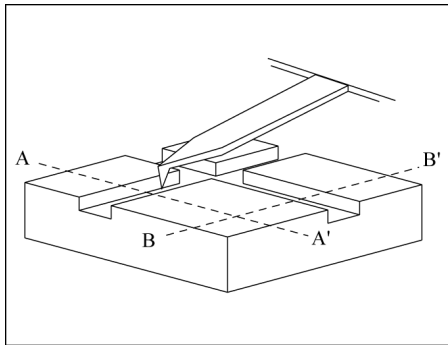
- 2) Place the chip on the adhesive stick gently against the prescribed part in your chip holder. (see left below)
- 3) Press the center of the chip with sharp pointed tweezers and pull apart the stick from the chip. (see right below)
- 4) Lock the chip into the chip holder in accordance with the manner described in the manual of your SPM. Most of the chip holders in AFMs use a leaf spring or a wire for pressing the chip to the holder. It is recommended that the chip be pressed with those at the center of the chip to achieve a good mechanical coupling between the chip and the holder.



Note : To avoid contact with the cantilever, the tweezers should not access to the chip from cantilever side. Put the tweezers on the chip like following illustration.



5 Tip shape of Tetrahedral tip



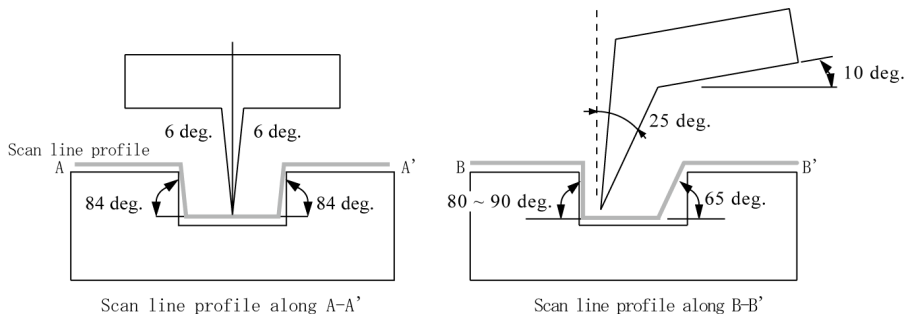
As can be seen in the left illustration, a Blade tetrahedral tip is located at the exact end of the cantilever.

The finite tip shape will determine the scan line profile as in the illustrations below.

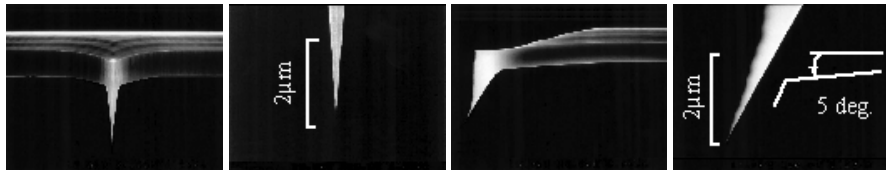
The tip profile is symmetric with a half tip angle of typically 6 degrees at last 2 μm of the tip from its front side (see left below).

The side tip profile is asymmetric with a tip angle of 23 degrees. Then the cantilever chip is attached to a chip holder in your AFM with an angle, about 10 degrees, the asymmetry is improved (see right below).

Furthermore, the apex of the tetrahedral tip becomes sharper due to an oxide sharpening process.



Tip shape and scan line profile



Front view

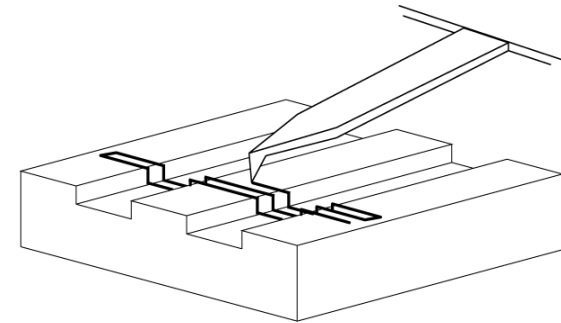
Front view of the apex

Side view

Side view of the apex when the lever is inclined at 5 deg.

SEM images of the Blade tetra tip

When you set your samples to your instrument, please consider the unique shape of the tetrahedral tip, that is 'good symmetry', when viewing from its front side and choose the direction of the sample. When measuring long grooves, you can get an idea of what angle of the cut will be quickly by aligning the cantilever along the grooves and scanning across at right angles against grooves (see below).



Cantilever, sample and fast scan direction

6 Information

Please contact following if you have any question on this user's manual.

OLYMPUS CORPORATION
 Microtechnology R&D Division
 2-3 Kuboyama-cho Hachioji-shi Tokyo 192-8512 Japan
 email : probe@olympus.co.jp

Please access to the web page of OLYMPUS micro cantilevers.

<http://www.olympus.co.jp/probe>